

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/605,636	LEE ET AL.	
Examiner	Art Unit	
Ryan M. Stiglic	2112	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
consulted Paul Myers; re: Prior Art	9/12/2005		
See East search notes			
7/0/313,314 and USb			
711/103,115 and usb			